

<b>Notice of References Cited</b>	Application/Control No. 10/795,952	Applicant(s)/Patent Under Reexamination KOMURA ET AL.	
	Examiner Tony Chuo	Art Unit 1745	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0028975	02-2004	Badding et al.	429/32
*	B	US-5,942,348	08-1999	Jansing et al.	429/32
*	C	US-5,547,777	08-1996	Richards, William R.	429/32
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 63-279578	11-1988	Japan	Ide et al	H01M8/24
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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